

<b>Notice of References Cited</b>	Application/Control No. 10/594,784		Applicant(s)/Patent Under Reexamination ONO ET AL.	
	Examiner KARUNA P. REDDY		Art Unit 1796	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,157,083 A	10-1992	Aonuma et al.	525/285
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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